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<b>Substitute for form 1449A/B/PTO</b>  <b>INFORMATION DISCLOSURE STATEMENT BY APPLICANT</b>  (Use as many sheets as necessary)			<b>Complete if Known</b>		
			Application Number	10/776,687 - Conf. # 3813	
			Filing Date	February 10, 2004	
			First Named Inventor	Gregory B. Altshuler	
			Art Unit	3732	
			Examiner Name	Not Yet Assigned	
Sheet	1	of	3	Attorney Docket Number	105090-0236

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